

Dual N-channel MOSFET

KFC6B22500L

Datasheet

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1. GENERAL DESCRIPTION

Gate resistor installed Dual N-channel MOSFET for lithium-ion secondary battery protection circuits.

2. FEATURES

- Source-source On-state Resistance: $R_{SS(on)}$ typ = 8.3 m Ω (V_{GS} = 3.8 V)
- CSP (Chip Size Package)
- Halogen-free / RoHS compliant (EU RoHS / UL-94 V-0 / MSL: Level 1)

3. MARKING SYMBOL: 3S

4. PACKAGING

Embossed type (Thermo-compression sealing): 10,000 pcs / reel (standard)

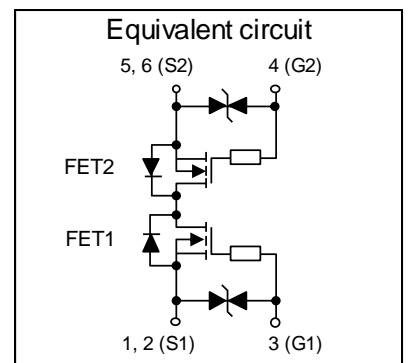
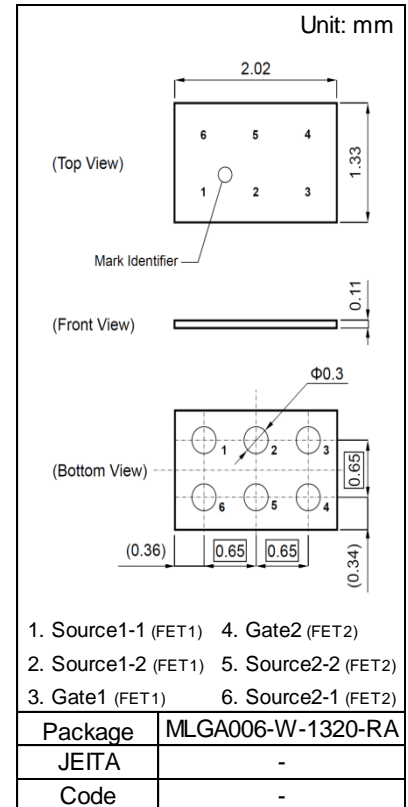
5. ABSOLUTE MAXIMUM RATINGS $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Source-source Voltage	VSS	20	V
Gate-source Voltage	VGS	± 12	V
Source Current	DC ^{*1}	IS1	A
	DC ^{*2}	IS2	
	DC ^{*3}	IS3	
	Pulsed ^{*4}	ISp	
Total Power Dissipation	DC ^{*1}	PD1	W
	DC ^{*2}	PD2	
	DC ^{*3}	PD3	
Operating Junction and Storage Temperature Range	Tj, Tstg	- 55 to + 150	$^\circ\text{C}$

6. THERMAL CHARACTERISTICS $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Thermal Resistance (ch-a)	Rth1 ^{*1}	284	$^\circ\text{C} / \text{W}$
	Rth2 ^{*2}	83	
	Rth3 ^{*3}	52	

- Note
- *1 Mounted on FR4 board (25.4 mm x 25.4 mm x t1.0 mm).
FR4 board partially covered with copper pad (30 mm² area, 36 μm thickness).
 - *2 Mounted on FR4 board (25.4 mm x 25.4 mm x t1.0 mm).
FR4 board fully covered with copper pad (610 mm² area, 36 μm thickness).
 - *3 Mounted on ceramic board (70 mm x 70 mm x t1.0 mm).
 - *4 $t = 10 \mu\text{s}$, Duty Cycle $\leq 1\%$.



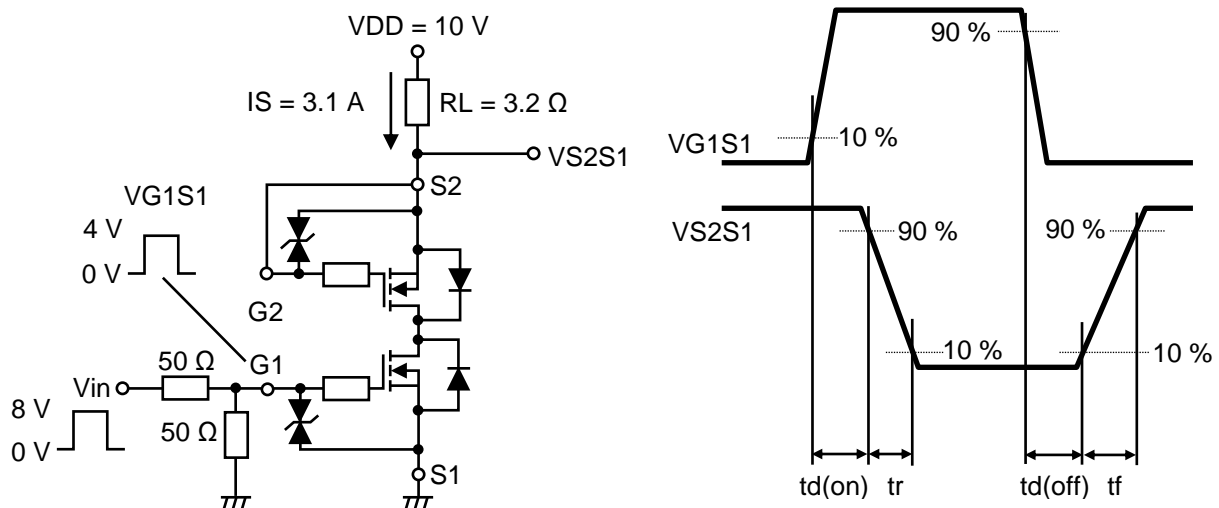
7. ELECTRICAL CHARACTERISTICS $T_a = 25\text{ }^{\circ}\text{C} \pm 3\text{ }^{\circ}\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Source-source Breakdown Voltage	VSSS	$I_S = 1\text{ mA}$, $V_{GS} = 0\text{ V}$	20			V
Zero Gate Voltage Source Current	ISSS	$V_{SS} = 20\text{ V}$, $V_{GS} = 0\text{ V}$			1	μA
Gate-source Leakage Current	IGSS1	$V_{GS} = \pm 8\text{ V}$, $V_{SS} = 0\text{ V}$			± 10	μA
	IGSS2	$V_{GS} = \pm 5\text{ V}$, $V_{SS} = 0\text{ V}$			± 1	
Gate-source Threshold Voltage	V_{th}	$I_S = 0.57\text{ mA}$, $V_{SS} = 10\text{ V}$	0.35	0.90	1.40	V
Source-source On-state Resistance	RSS(on)1	$I_S = 3.1\text{ A}$, $V_{GS} = 4.5\text{ V}$	5.2	7.9	10.3	$\text{m}\Omega$
	RSS(on)2	$I_S = 3.1\text{ A}$, $V_{GS} = 3.8\text{ V}$	5.5	8.3	10.8	
	RSS(on)3	$I_S = 3.1\text{ A}$, $V_{GS} = 3.1\text{ V}$	5.8	9.2	14.7	
	RSS(on)4	$I_S = 3.1\text{ A}$, $V_{GS} = 2.5\text{ V}$	6.3	11.1	21.8	
Body Diode Forward Voltage	$V_{F(s-s)}$	$I_F = 3.1\text{ A}$, $V_{GS} = 0\text{ V}$		0.7	1.2	V
Input Capacitance ^{*1}	C_{iss}	$V_{SS} = 10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ kHz}$		1600		pF
Output Capacitance ^{*1}	C_{oss}			165		
Reverse Transfer Capacitance ^{*1}	C_{rss}			130		
Turn-on Delay Time ^{*1, *2}	$t_{d(on)}$	$V_{DD} = 10\text{ V}$, $V_{GS} = 0\text{ to }4\text{ V}$		0.4		μs
Rise Time ^{*1, *2}	t_r	$I_S = 3.1\text{ A}$		0.9		
Turn-off Delay Time ^{*1, *2}	$t_{d(off)}$	$V_{DD} = 10\text{ V}$, $V_{GS} = 4\text{ to }0\text{ V}$		2.1		μs
Fall Time ^{*1, *2}	t_f	$I_S = 3.1\text{ A}$		1.4		
Total Gate Charge ^{*1}	Q_g	$V_{DD} = 10\text{ V}$		13		nC
Gate-source Charge ^{*1}	Q_{gs}	$V_{GS} = 0\text{ to }4\text{ V}$		5.2		
Gate-drain Charge ^{*1}	Q_{gd}	$I_S = 6.2\text{ A}$		4.0		

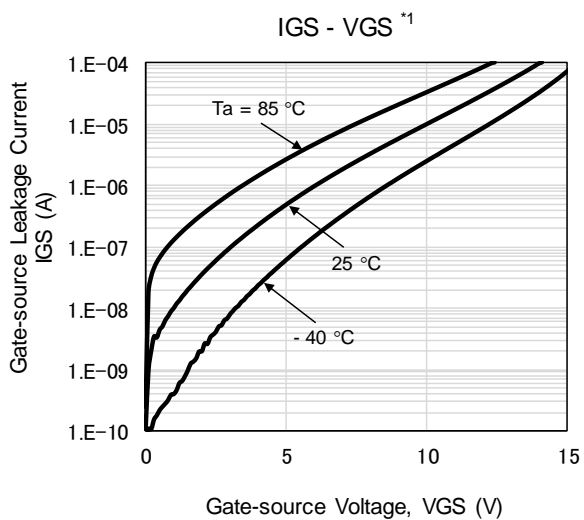
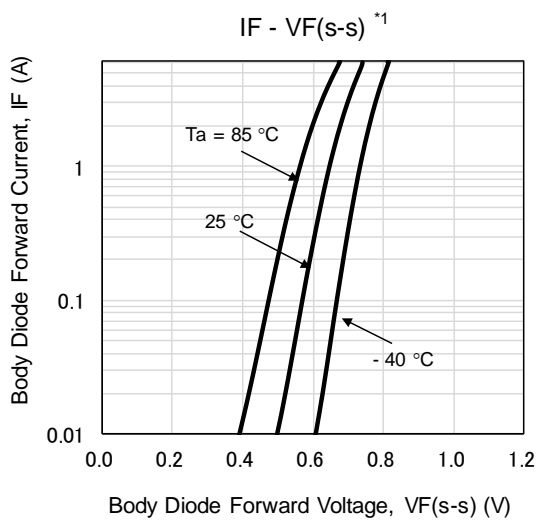
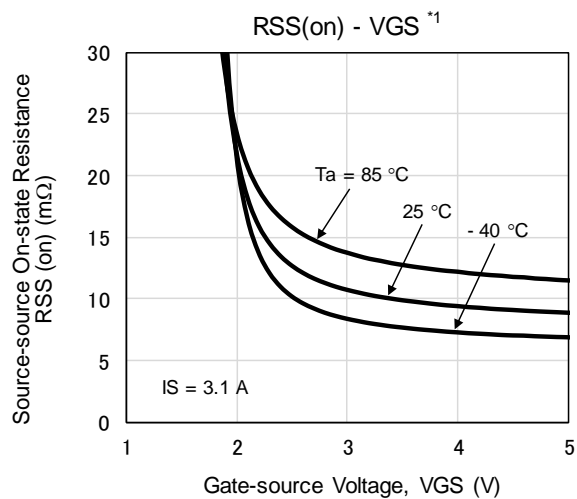
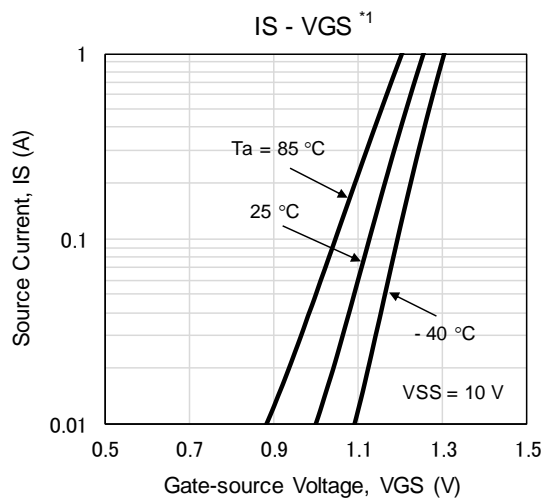
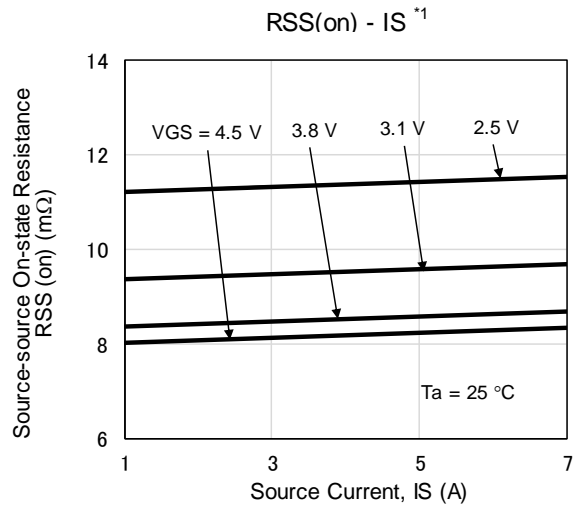
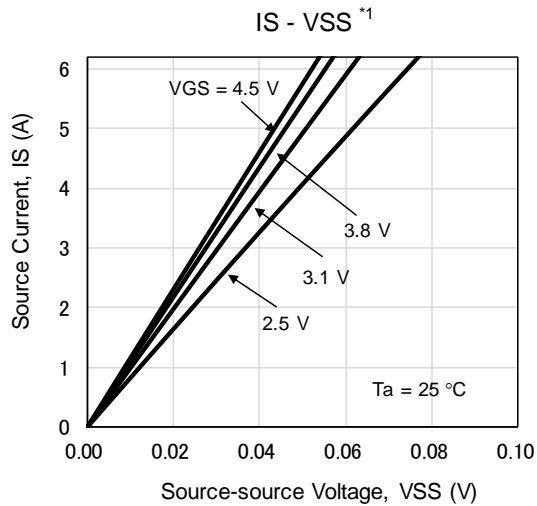
Note Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 Measuring methods for transistors.

*1 Guaranteed by design, not subject to production testing.

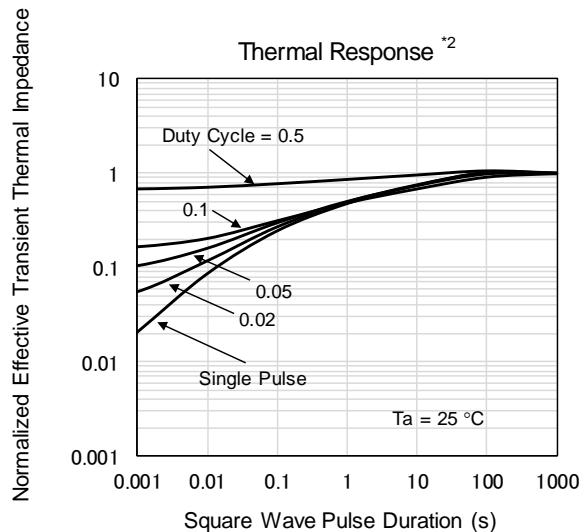
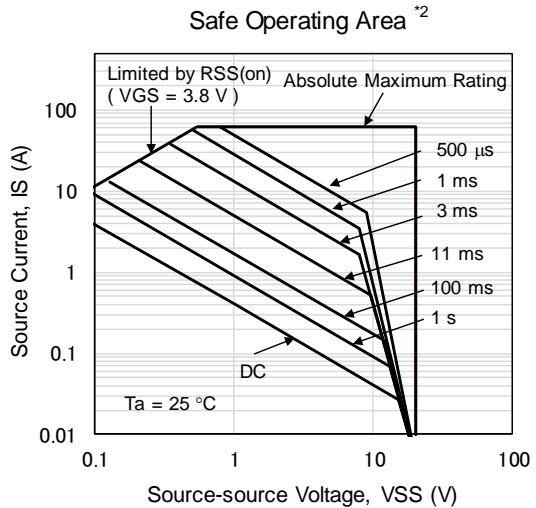
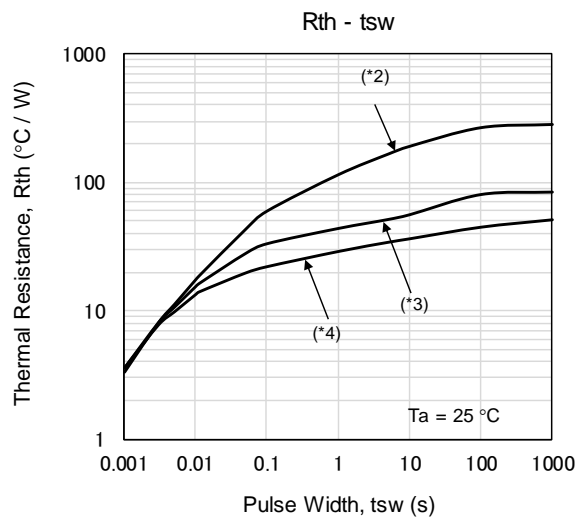
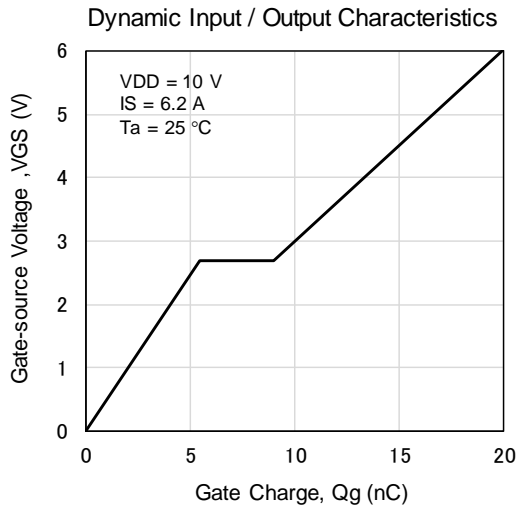
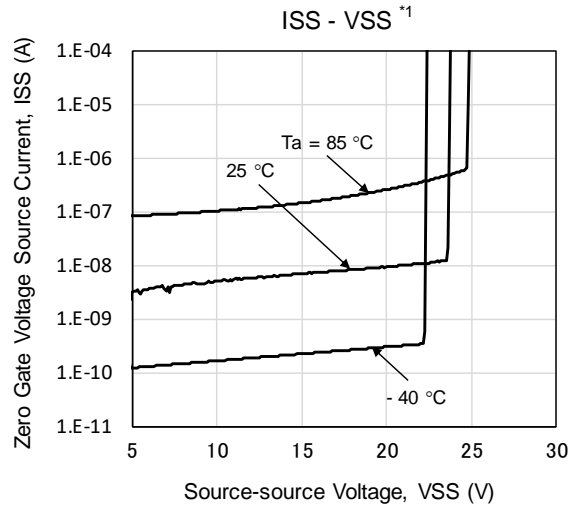
*2 Measurement circuit for Turn-on Delay Time / Rise Time / Turn-off Delay Time / Fall Time.



8. TECHNICAL DATA (Reference)



TECHNICAL DATA (Reference)



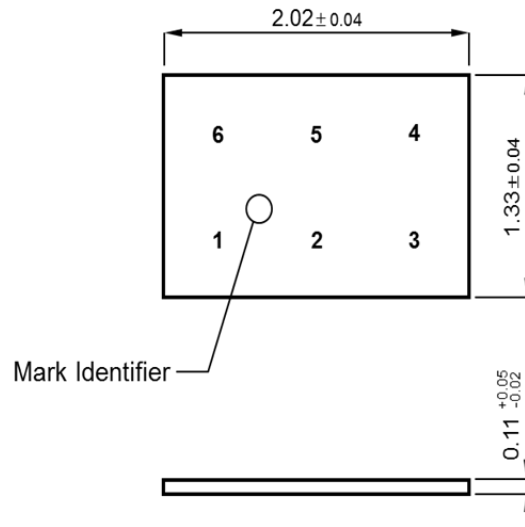
Note

- *1 Pulse measurement.
- *2 Mounted on FR4 board (25.4 mm x 25.4 mm x t1.0 mm).
FR4 board partially covered with copper pad (30 mm² area, 36 μm thickness).
- *3 Mounted on FR4 board (25.4 mm x 25.4 mm x t1.0 mm).
FR4 board fully covered with copper pad (610 mm² area, 36 μm thickness).
- *4 Mounted on Ceramic board (70 mm x 70 mm x t1.0 mm).

9. OUTLINE

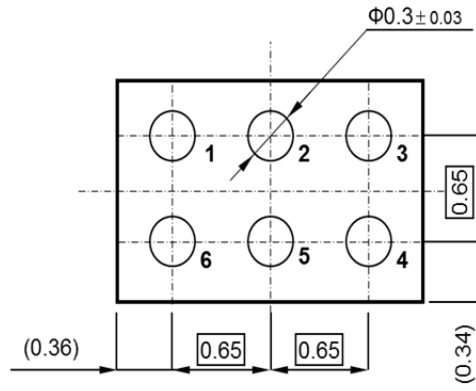
(Top View)

Unit: mm



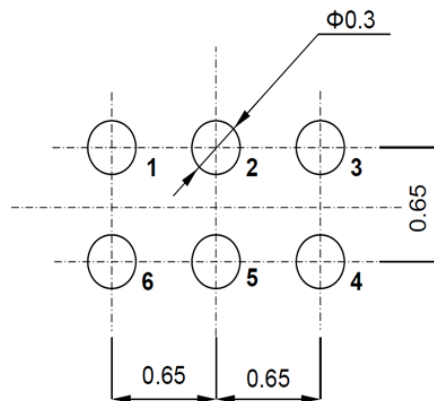
(Front View)

(Bottom View)



10. LAND & STENCIL PATTERN (Reference)

Unit: mm



Important notice:

Solder Mask Defined (SMD) pattern is strongly recommended for pad design.

Please check the information in the Nuvoton WL-CSP Application Notes about mounting process.

11. REVISION HISTORY

Date	Revision	Description
2021.10.28	1.00	1. Initially issued.

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